

Notice of References Cited	Application/Control No. 10/621,451	Applicant(s)/Patent Under Reexamination TANAKA, YOSHIYUKI	
	Examiner Hien N. Nguyen	Art Unit 2824	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,091,643	07-2000	Kawakami, Yukitoshi	365/185.29
	B	US-6,831,865	12-2004	Chang et al.	365/185.33
	C	US-6,058,047	05-2000	Kikuchi, Shuichi	365/185.33
	D	US-6,240,032	05-2001	Fukumoto, Katsumi	365/222
	E	US-6,654,286	11-2003	Kawakami, Yukitoshi	365/185.21
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP408124393A	05-1996	JAPAN	IWAMOTO et al.	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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